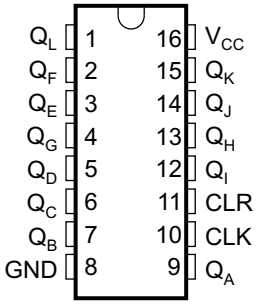
## FEATURES

- **Controlled Baseline**
  - **One Assembly**
  - **Test Site**
  - **One Fabrication Site**
- **Extended Temperature Performance of –55°C to 125°C**
- **Enhanced Diminishing Manufacturing Sources (DMS) Support**
- **Enhanced Product-Change Notification**
- **Qualification Pedigree** (1)
- **2-V to 5.5-V $V_{CC}$ Operation**
- **Typical $V_{OLP}$ (Output Ground Bounce) <0.8 V at $V_{CC}$ = 3.3 V, $T_A$ = 25°C**
- **Typical $V_{OHV}$ (Output $V_{OH}$ Undershoot) >2.3 V at $V_{CC}$ = 3.3 V, $T_A$ = 25°C**
- **Support Mixed-Mode Voltage Operation on All Ports**
- **High On-Off Output-Voltage Ratio**
- **Low Crosstalk Between Switches**
- **Individual Switch Controls**
- **Extremely Low Input Current**
- **$I_{off}$ Supports Partial-Power-Down Mode Operation**
- **Latch-Up Performance Exceeds 100 mA Per JESD 78, Class II**
- **ESD Protection Exceeds JESD 22**
  - **2000-V Human-Body Model (A114-A)**
  - **200-V Machine Model (A115-A)**
  - **1000-V Charged-Device Model (C101)**

(1) Component qualification in accordance with JEDEC and industry standards to ensure reliable operation over an extended temperature range. This includes, but is not limited to, Highly Accelerated Stress Test (HAST) or biased 85/85, temperature cycle, autoclave or unbiased HAST, electromigration, bond intermetallic life, and mold compound life. Such qualification testing should not be viewed as justifying use of this component beyond specified performance and environmental limits.

**SN74LV4040A . . . PW PACKAGE**
**(TOP VIEW)**




## DESCRIPTION/ORDERING INFORMATION

The SN74LV4040A device is a 12 bit asynchronous binary counter with the outputs of all stages available externally. A high level at the clear (CLR) input asynchronously clears the counter and resets all outputs low. The count is advanced on a high-to-low transition at the clock (CLK) input. Applications include time-delay circuits, counter controls, and frequency-dividing circuits.

This device is fully specified for partial-power-down applications using $I_{off}$. The $I_{off}$ circuitry disables the outputs, preventing damaging current backflow through the devices when they are powered down.

**ORDERING INFORMATION**(1)

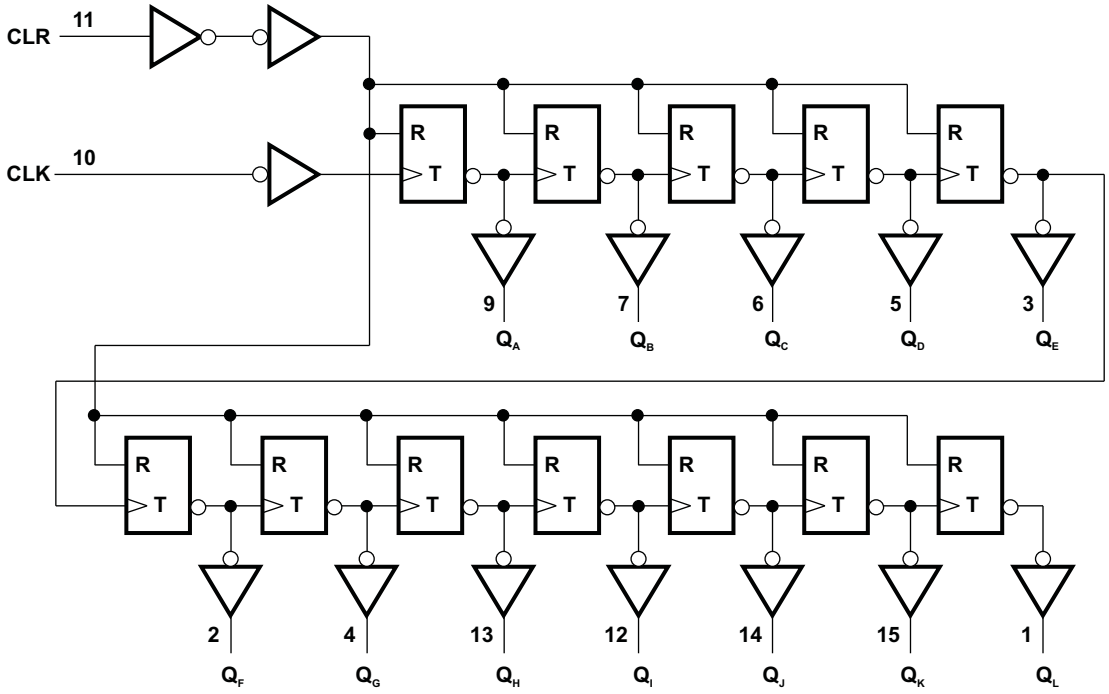
| $T_A$ | PACKAGE(2) | | ORDERABLE PART NUMBER | TOP-SIDE MARKING |
|---|---|---|---|---|
| –55°C to 125°C | TSSOP – PW | Reel of 2000 | SN74LV4040AMPWREP | LW040A |

(1) For the most current package and ordering information, see the Package Option Addendum at the end of this document, or see the TI website at www.ti.com.
(2) Package drawings, thermal data, and symbolization are available at www.ti.com/packaging.

### FUNCTION TABLE
### (each buffer)

| INPUTS | | FUNCTION |
|---|---|---|
| CLK | CLR | |
| ↑ | L | No change |
| ↓ | L | Advance to next stage |
| X | H | All outputs L |

### LOGIC DIAGRAM (POSITIVE LOGIC)




## Absolute Maximum Ratings(1)

over operating free-air temperature range (unless otherwise noted)

| | | | MIN | MAX | UNIT |
|---|---|---|---|---|---|
| $V_{CC}$ | Supply voltage range | | –0.5 | 7 | V |
| $V_I$ | Input voltage range(2) | | –0.5 | 7 | V |
| $V_O$ | Voltage range applied to any output in the high-impedance or power-off state(2) | | –0.5 | 7 | V |
| $V_O$ | Output voltage range(2)(3) | | –0.5 | $V_{CC}$ + 0.5 | V |
| $I_{IK}$ | Input clamp current | $V_I$ < 0 | | –20 | mA |
| $I_{OK}$ | Output clamp current | $V_O$ < 0 | | –50 | mA |
| $I_O$ | Continuous output current | $V_O$ = 0 to $V_{CC}$ | | ±25 | mA |
| | Continuous current through $V_{CC}$ or GND | | | ±50 | mA |
| $\theta_{JA}$ | Package thermal impedance(4) | | | 108 | °C/W |
| $T_{stg}$ | Storage temperature range | | –65 | 150 | °C |

(1) Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.
(2) The input and output negative-voltage ratings may be exceeded if the input and output current ratings are observed.
(3) This value is limited to 5.5 V maximum.
(4) The package thermal impedance is calculated in accordance with JESD 51-7.

## Recommended Operating Conditions(1)

| | | | MIN | MAX | UNIT |
|---|---|---|---|---|---|
| $V_{CC}$ | Supply voltage | | 2 | 5.5 | V |
| $V_{IH}$ | High-level input voltage | $V_{CC}$ = 2 V | 1.5 | | V |
| | | $V_{CC}$ = 2.3 to 2.7 V | $V_{CC} \times 0.7$ | | |
| | | $V_{CC}$ = 3 V to 3.6 V | $V_{CC} \times 0.7$ | | |
| | | $V_{CC}$ = 4.5 to 5.5 V | $V_{CC} \times 0.7$ | | |
| $V_{IL}$ | Low-level input voltage | $V_{CC}$ = 2 V | | 0.5 | V |
| | | $V_{CC}$ = 2.3 to 2.7 V | | $V_{CC} \times 0.3$ | |
| | | $V_{CC}$ = 3 V to 3.6 V | | $V_{CC} \times 0.3$ | |
| | | $V_{CC}$ = 4.5 to 5.5 V | | $V_{CC} \times 0.3$ | |
| $V_I$ | Input voltage | | 0 | 5.5 | V |
| $V_O$ | Output voltage | | 0 | $V_{CC}$ | V |
| $I_{OH}$ | High-level output current | $V_{CC}$ = 2 V | | –50 | mA |
| | | $V_{CC}$ = 2.3 to 2.7 V | | –2 | |
| | | $V_{CC}$ = 3 V to 3.6 V | | –6 | |
| | | $V_{CC}$ = 4.5 to 5.5 V | | –12 | |
| $I_{OL}$ | Low-level output current | $V_{CC}$ = 2 V | | 50 | μA |
| | | $V_{CC}$ = 2.3 to 2.7 V | | 2 | mA |
| | | $V_{CC}$ = 3 V to 3.6 V | | 6 | |
| | | $V_{CC}$ = 4.5 to 5.5 V | | 12 | |
| Δt/Δv | Input transition rise or fall rate | $V_{CC}$ = 2.3 to 2.7 V | | 200 | ns/V |
| | | $V_{CC}$ = 3 V to 3.6 V | | 100 | |
| | | $V_{CC}$ = 4.5 to 5.5 V | | 20 | |
| $T_A$ | Operating free-air temperature | | –55 | 125 | °C |

(1) All unused inputs of the device must be held at $V_{CC}$ or GND to ensure proper device operation. Refer to the TI application report, *Implications of Slow or Floating CMOS Inputs*, literature number SCBA004.

## Electrical Characteristics

over recommended operating free-air temperature range (unless otherwise noted)

| PARAMETER | TEST CONDITIONS | $V_{CC}$ | MIN | TYP | MAX | UNIT |
|---|---|---|---|---|---|---|
| $V_{OH}$ | $I_{OH}$ = –50 μA | 2 V to 5.5 V | $V_{CC}$ – 0.1 | | | V |
| | $I_{OH}$ = –2 mA | 2.3 V | 2 | | | |
| | $I_{OH}$ = –6 mA | 3 V | 2.48 | | | |
| | $I_{OH}$ = –12 mA | 4.5 V | 3.8 | | | |
| $V_{OL}$ | $I_{OL}$ = 50 μA | 2 V to 5.5 V | | | 0.1 | V |
| | $I_{OL}$ = 2 mA | 2.3 V | | | 0.4 | |
| | $I_{OL}$ = 6 mA | 3 V | | | 0.44 | |
| | $I_{OL}$ = 12 mA | 4.5 V | | | 0.55 | |
| $I_I$ | $V_I$ = 5.5 V or GND | 0 to 5.5 V | | | ±1 | μA |
| $I_{CC}$ | $V_I$ = $V_{CC}$ or GND, $I_O$ = 0 | 5.5 V | | | 20 | μA |
| $I_{off}$ | $V_I$ or $V_O$ = 0 to 5.5 V | 0 | | | 5 | μA |
| $C_i$ | $V_I$ = $V_{CC}$ or GND | 3.3 V | | 1.9 | | pF |

## Timing Requirements

over recommended operating free-air temperature range, $V_{CC}$ = 2.5 V ± 0.2 V (unless otherwise noted) (see Figure 1)

| | | | $T_A$ = 25°C | | MIN | MAX | UNIT |
|---|---|---|---|---|---|---|---|
| | | | MIN | MAX | | | |
| $t_w$ | Pulse duration | CLK high or low | 7 | | 7 | | ns |
| | | CLR high | 6.5 | | 6.5 | | |
| $t_{su}$ | Setup time | CLR inactive before CLK↓ | 6.5 | | 6.5 | | ns |

## Timing Requirements

over recommended operating free-air temperature range, $V_{CC}$ = 3.3 V ± 0.3 V (unless otherwise noted) (see Figure 1)

| | | | $T_A$ = 25°C | | MIN | MAX | UNIT |
|---|---|---|---|---|---|---|---|
| | | | MIN | MAX | | | |
| $t_w$ | Pulse duration | CLK high or low | 5 | | 5 | | ns |
| | | CLR high | 5 | | 5 | | |
| $t_{su}$ | Setup time | CLR inactive before CLK↓ | 5 | | 5 | | ns |

## Timing Requirements

over recommended operating free-air temperature range, $V_{CC}$ = 5 V ± 0.5 V (unless otherwise noted) (see Figure 1)

| | | | $T_A$ = 25°C | | MIN | MAX | UNIT |
|---|---|---|---|---|---|---|---|
| | | | MIN | MAX | | | |
| $t_w$ | Pulse duration | CLK high or low | 5 | | 5 | | ns |
| | | CLR high | 5 | | 5 | | |
| $t_{su}$ | Setup time | CLR inactive before CLK↓ | 5 | | 5 | | ns |

## Switching Characteristics

over recommended operating free-air temperature range, $V_{CC}$ = 2.5 V ± 0.2 V (unless otherwise noted) (see Figure 1)

| PARAMETER | FROM (INPUT) | TO (OUTPUT) | LOAD CAPACITANCE | $T_A$ = 25°C | | | MIN | MAX | UNIT |
|---|---|---|---|---|---|---|---|---|---|
| | | | | MIN | TYP | MAX | | | |
| $f_{max}$ | | | $C_L$ = 50 pF | 40 | 95 | | 35 | | MHz |
| $t_{PLH}$ | $\overline{CLK}$ | $Q_A$ | $C_L$ = 50 pF | | 10.5 | 24.1 | 1 | 28 | ns |
| $t_{PHL}$ | | | | | 10.5 | 24.1 | 1 | 28 | |
| $t_{PHL}$ | CLR | Any Q | $C_L$ = 50 pF | | 11.7 | 24.5 | 1 | 28 | ns |
| $\Delta t_{pd}$ | $Q_n$ | $Q_{n+1}$ | $C_L$ = 50 pF | | 1.7 | 11.1 | | 10.8 | ns |

## Switching Characteristics

over recommended operating free-air temperature range, $V_{CC}$ = 3.3 V ± 0.3 V (unless otherwise noted) (see Figure 1)

| PARAMETER | FROM (INPUT) | TO (OUTPUT) | LOAD CAPACITANCE | $T_A$ = 25°C | | | MIN | MAX | UNIT |
|---|---|---|---|---|---|---|---|---|---|
| | | | | MIN | TYP | MAX | | | |
| $f_{max}$ | | | $C_L$ = 50 pF | 55 | 130 | | 50 | | MHz |
| $t_{PLH}$ | $\overline{CLK}$ | $Q_A$ | $C_L$ = 50 pF | | 7.5 | 15.4 | 1 | 17.5 | ns |
| $t_{PHL}$ | | | | | 7.5 | 15.4 | 1 | 17.5 | |
| $t_{PHL}$ | CLR | Any Q | $C_L$ = 50 pF | | 9 | 16.3 | 1 | 18.5 | ns |
| $\Delta t_{pd}$ | $Q_n$ | $Q_{n+1}$ | $C_L$ = 50 pF | | 1.2 | 5.4 | | 6.6 | ns |

## Switching Characteristics

over recommended operating free-air temperature range, $V_{CC}$ = 5 V ± 0.5 V (unless otherwise noted) (see Figure 1)

| PARAMETER | FROM (INPUT) | TO (OUTPUT) | LOAD CAPACITANCE | $T_A$ = 25°C | | | MIN | MAX | UNIT |
|---|---|---|---|---|---|---|---|---|---|
| | | | | MIN | TYP | MAX | | | |
| $f_{max}$ | | | $C_L$ = 50 pF | 95 | 185 | | 80 | | MHz |
| $t_{PLH}$ | $\overline{CLK}$ | $Q_A$ | $C_L$ = 50 pF | | 5.3 | 9.3 | 1 | 10.5 | ns |
| $t_{PHL}$ | | | | | 5.3 | 9.3 | 1 | 10.5 | |
| $t_{PHL}$ | CLR | Any Q | $C_L$ = 50 pF | | 6.8 | 10.6 | 1 | 12 | ns |
| $\Delta t_{pd}$ | $Q_n$ | $Q_{n+1}$ | $C_L$ = 50 pF | | 0.8 | 4.0 | | 5.5 | ns |

## Noise Characteristics

$V_{CC}$ = 3.3 V, $C_L$ = 50 pF, $T_A$ = 25°C (1)

| PARAMETER | | MIN | TYP | MAX | UNIT |
|---|---|---|---|---|---|
| $V_{OL(P)}$ | Quiet output, maximum dynamic $V_{OL}$ | | 0.5 | 0.8 | V |
| $V_{OL(V)}$ | Quiet output, minimum dynamic $V_{OL}$ | | –0.5 | –0.8 | V |
| $V_{IH(D)}$ | High-level dynamic input voltage | 2.31 | | | V |
| $V_{IL(D)}$ | Low-level dynamic input voltage | | | 0.99 | V |

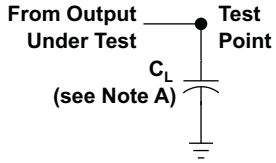
(1) Characteristics are for surface-mount packages only.

## Operating Characteristics

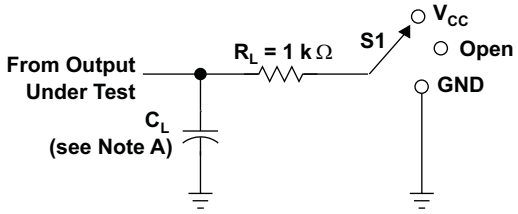
$T_A$ = 25°C

| PARAMETER | | TEST CONDITIONS | | $V_{CC}$ | TYP | UNIT |
|---|---|---|---|---|---|---|
| $C_{pd}$ | Power dissipation capacitance | $C_L$ = 50 pF, | f = 10 MHz | 3.3 V | 11.9 | pF |
| | | | | 5 V | 13.1 | |

## PARAMETER MEASUREMENT INFORMATION

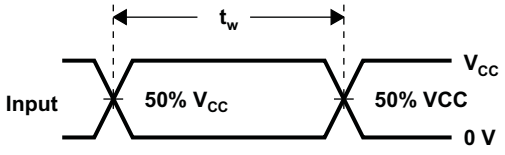



LOAD CIRCUIT FOR
TOTEM-POLE OUTPUTS

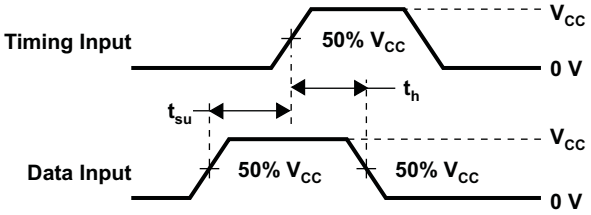



LOAD CIRCUIT FOR
3-STATE AND OPEN-DRAIN OUTPUTS

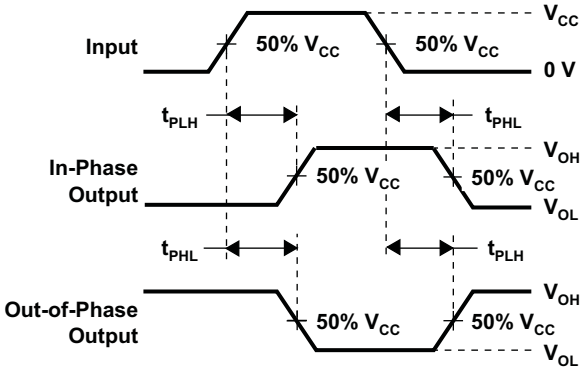
| TEST | S1 |
|---|---|
| $t_{PLH}/t_{PHL}$ | Open |
| $t_{PLZ}/t_{PZL}$ | $V_{CC}$ |
| $t_{PHZ}/t_{PZH}$ | GND |
| Open Drain | $V_{CC}$ |



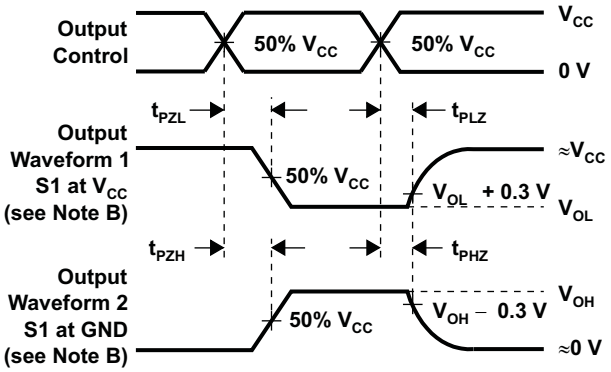

VOLTAGE WAVEFORMS
PULSE DURATION




VOLTAGE WAVEFORMS
SETUP AND HOLD TIMES




VOLTAGE WAVEFORMS
PROPAGATION DELAY TIMES
INVERTING AND NONINVERTING OUTPUTS




VOLTAGE WAVEFORMS
ENABLE AND DISABLE TIMES
LOW- AND HIGH-LEVEL ENABLING

NOTES: A. $C_L$ includes probe and jig capacitance.
B. Waveform 1 is for an output with internal conditions such that the output is low, except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high, except when disabled by the output control.
C. All input pulses are supplied by generators having the following characteristics: PRR ≤ 1 Mhz, $Z_O$ = 50 Ω, $t_r$ ≤ 3 ns, $t_f$ ≤ 3 ns.
D. The outputs are measured one at a time, with one input transition per measurement.
E. All parameters and waveforms are not applicable to all devices.

**Figure 1. Load Circuit and Voltage Waveforms**

## PACKAGING INFORMATION

| Orderable Device | Status (1) | Package Type | Package Drawing | Pins | Package Qty | Eco Plan (2) | Lead/Ball Finish | MSL Peak Temp (3) |
|---|---|---|---|---|---|---|---|---|
| SN74LV4040AMPWREP | ACTIVE | TSSOP | PW | 16 | 2000 | Green (RoHS & no Sb/Br) | CU NIPDAU | Level-1-260C-UNLIM |
| V62/07630-01XE | ACTIVE | TSSOP | PW | 16 | 2000 | Green (RoHS & no Sb/Br) | CU NIPDAU | Level-1-260C-UNLIM |

(1) The marketing status values are defined as follows:
**ACTIVE:** Product device recommended for new designs.
**LIFEBUY:** TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.
**NRND:** Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.
**PREVIEW:** Device has been announced but is not in production. Samples may or may not be available.
**OBSOLETE:** TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.
**TBD:** The Pb-Free/Green conversion plan has not been defined.
**Pb-Free (RoHS):** TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.
**Pb-Free (RoHS Exempt):** This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.
**Green (RoHS & no Sb/Br):** TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

(3) MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

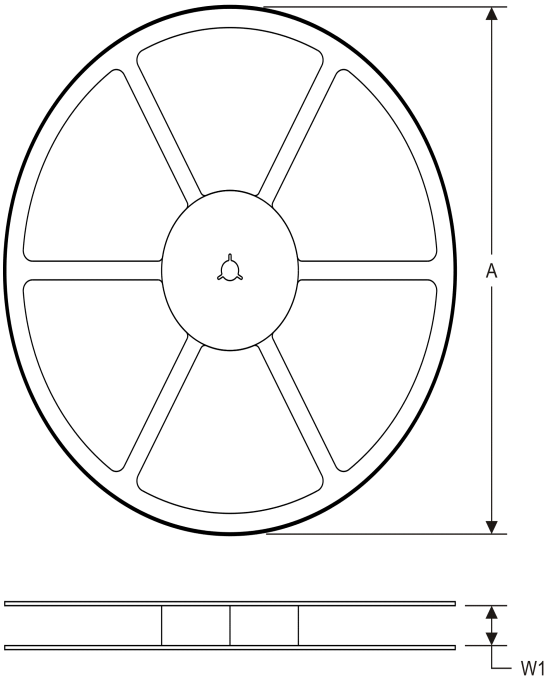


**OTHER QUALIFIED VERSIONS OF SN74LV4040A-EP :**
- Catalog: SN74LV4040A

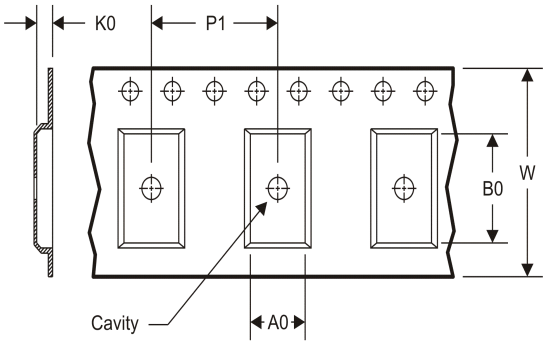
NOTE: Qualified Version Definitions:
- Catalog - TI's standard catalog product

## TAPE AND REEL INFORMATION

**REEL DIMENSIONS**




**TAPE DIMENSIONS**



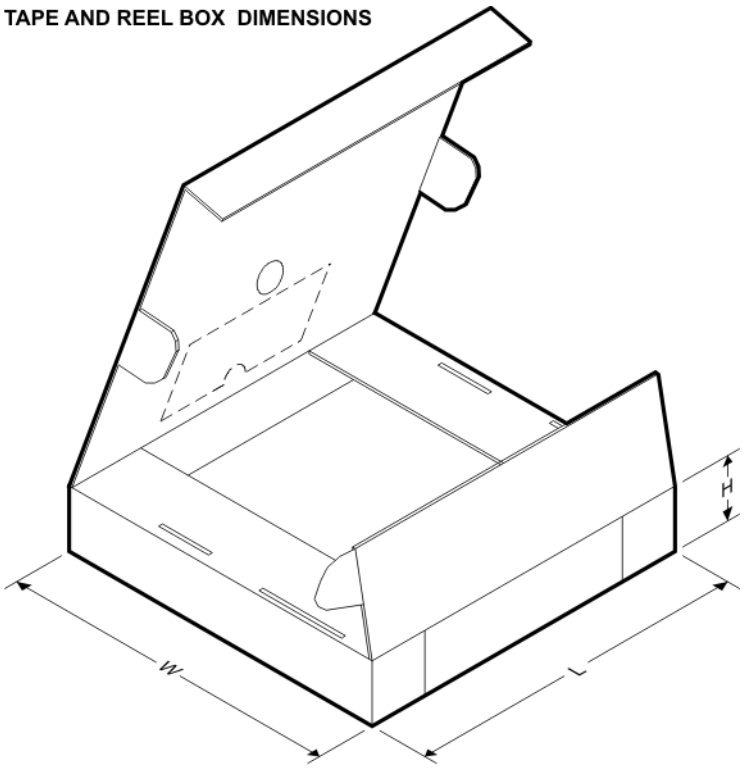

| | |
|---|---|
| A0 | Dimension designed to accommodate the component width |
| B0 | Dimension designed to accommodate the component length |
| K0 | Dimension designed to accommodate the component thickness |
| W | Overall width of the carrier tape |
| P1 | Pitch between successive cavity centers |

**TAPE AND REEL INFORMATION**

*All dimensions are nominal

| Device | Package Type | Package Drawing | Pins | SPQ | Reel Diameter (mm) | Reel Width W1 (mm) | A0 (mm) | B0 (mm) | K0 (mm) | P1 (mm) | W (mm) | Pin1 Quadrant |
|---|---|---|---|---|---|---|---|---|---|---|---|---|
| SN74LV4040AMPWREP | TSSOP | PW | 16 | 2000 | 330.0 | 12.4 | 6.9 | 5.6 | 1.6 | 8.0 | 12.0 | Q1 |

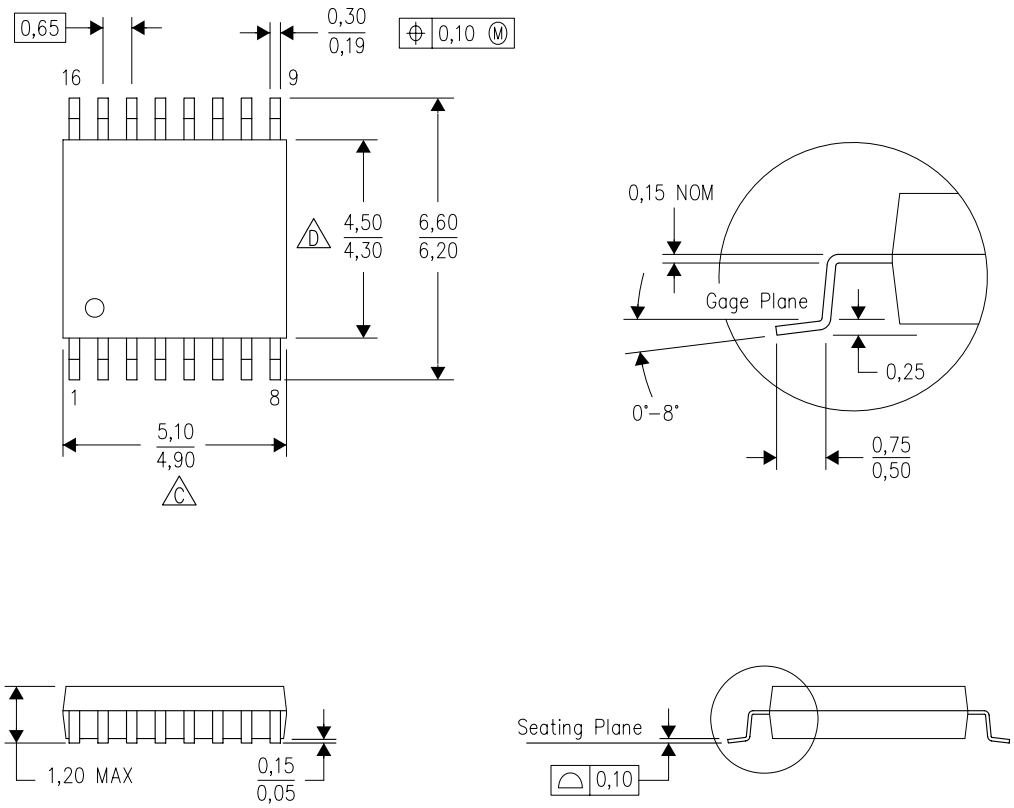
TAPE AND REEL BOX DIMENSIONS




*All dimensions are nominal

| Device | Package Type | Package Drawing | Pins | SPQ | Length (mm) | Width (mm) | Height (mm) |
|---|---|---|---|---|---|---|---|
| SN74LV4040AMPWREP | TSSOP | PW | 16 | 2000 | 367.0 | 367.0 | 35.0 |

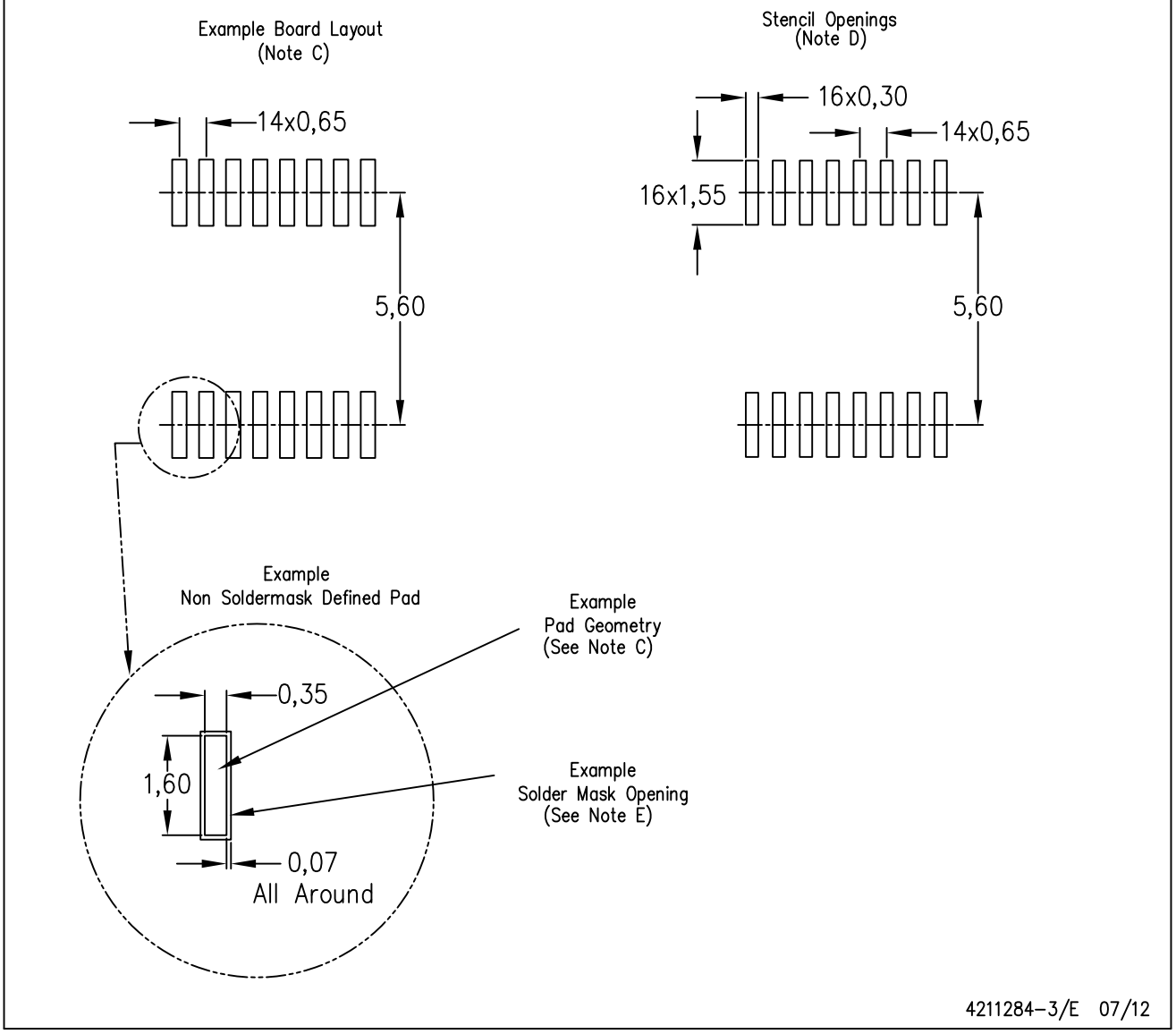
PW (R–PDSO–G16) PLASTIC SMALL OUTLINE




4040064–4/G 02/11

NOTES:
A. All linear dimensions are in millimeters. Dimensioning and tolerancing per ASME Y14.5M–1994.
B. This drawing is subject to change without notice.
C. Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0,15 each side.
D. Body width does not include interlead flash. Interlead flash shall not exceed 0,25 each side.
E. Falls within JEDEC MO–153

PW (R–PDSO–G16) PLASTIC SMALL OUTLINE




NOTES:
A. All linear dimensions are in millimeters.
B. This drawing is subject to change without notice.
C. Publication IPC–7351 is recommended for alternate designs.
D. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC–7525 for other stencil recommendations.
E. Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.

## IMPORTANT NOTICE

Texas Instruments Incorporated and its subsidiaries (TI) reserve the right to make corrections, enhancements, improvements and other changes to its semiconductor products and services per JESD46C and to discontinue any product or service per JESD48B. Buyers should obtain the latest relevant information before placing orders and should verify that such information is current and complete. All semiconductor products (also referred to herein as “components”) are sold subject to TI’s terms and conditions of sale supplied at the time of order acknowledgment.

TI warrants performance of its components to the specifications applicable at the time of sale, in accordance with the warranty in TI’s terms and conditions of sale of semiconductor products. Testing and other quality control techniques are used to the extent TI deems necessary to support this warranty. Except where mandated by applicable law, testing of all parameters of each component is not necessarily performed.

TI assumes no liability for applications assistance or the design of Buyers’ products. Buyers are responsible for their products and applications using TI components. To minimize the risks associated with Buyers’ products and applications, Buyers should provide adequate design and operating safeguards.

TI does not warrant or represent that any license, either express or implied, is granted under any patent right, copyright, mask work right, or other intellectual property right relating to any combination, machine, or process in which TI components or services are used. Information published by TI regarding third-party products or services does not constitute a license to use such products or services or a warranty or endorsement thereof. Use of such information may require a license from a third party under the patents or other intellectual property of the third party, or a license from TI under the patents or other intellectual property of TI.

Reproduction of significant portions of TI information in TI data books or data sheets is permissible only if reproduction is without alteration and is accompanied by all associated warranties, conditions, limitations, and notices. TI is not responsible or liable for such altered documentation. Information of third parties may be subject to additional restrictions.

Resale of TI components or services with statements different from or beyond the parameters stated by TI for that component or service voids all express and any implied warranties for the associated TI component or service and is an unfair and deceptive business practice. TI is not responsible or liable for any such statements.

Buyer acknowledges and agrees that it is solely responsible for compliance with all legal, regulatory and safety-related requirements concerning its products, and any use of TI components in its applications, notwithstanding any applications-related information or support that may be provided by TI. Buyer represents and agrees that it has all the necessary expertise to create and implement safeguards which anticipate dangerous consequences of failures, monitor failures and their consequences, lessen the likelihood of failures that might cause harm and take appropriate remedial actions. Buyer will fully indemnify TI and its representatives against any damages arising out of the use of any TI components in safety-critical applications.

In some cases, TI components may be promoted specifically to facilitate safety-related applications. With such components, TI’s goal is to help enable customers to design and create their own end-product solutions that meet applicable functional safety standards and requirements. Nonetheless, such components are subject to these terms.

No TI components are authorized for use in FDA Class III (or similar life-critical medical equipment) unless authorized officers of the parties have executed a special agreement specifically governing such use.

Only those TI components which TI has specifically designated as military grade or “enhanced plastic” are designed and intended for use in military/aerospace applications or environments. Buyer acknowledges and agrees that any military or aerospace use of TI components which have ***not*** been so designated is solely at the Buyer's risk, and that Buyer is solely responsible for compliance with all legal and regulatory requirements in connection with such use.

TI has specifically designated certain components which meet ISO/TS16949 requirements, mainly for automotive use. Components which have not been so designated are neither designed nor intended for automotive use; and TI will not be responsible for any failure of such components to meet such requirements.

| **Products** | | **Applications** | |
|---|---|---|---|
| Audio | www.ti.com/audio | Automotive and Transportation | www.ti.com/automotive |
| Amplifiers | amplifier.ti.com | Communications and Telecom | www.ti.com/communications |
| Data Converters | dataconverter.ti.com | Computers and Peripherals | www.ti.com/computers |
| DLP® Products | www.dlp.com | Consumer Electronics | www.ti.com/consumer-apps |
| DSP | dsp.ti.com | Energy and Lighting | www.ti.com/energy |
| Clocks and Timers | www.ti.com/clocks | Industrial | www.ti.com/industrial |
| Interface | interface.ti.com | Medical | www.ti.com/medical |
| Logic | logic.ti.com | Security | www.ti.com/security |
| Power Mgmt | power.ti.com | Space, Avionics and Defense | www.ti.com/space-avionics-defense |
| Microcontrollers | microcontroller.ti.com | Video and Imaging | www.ti.com/video |
| RFID | www.ti-rfid.com | | |
| OMAP Mobile Processors | www.ti.com/omap | **TI E2E Community** | e2e.ti.com |
| Wireless Connectivity | www.ti.com/wirelessconnectivity | | |

Mailing Address: Texas Instruments, Post Office Box 655303, Dallas, Texas 75265